

CuO free p-Cu₂O nano-surfaces prepared by oxidizing copper sheets with a slow heating rate exhibiting the highest photocurrent and the H₂ evaluation rate

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Introduction

Among the various metal oxide materials for solar energy applications, p-type cuprous oxide (p-Cu₂O) is a promising non-toxic and low cost semiconductor with attracted attention for many decades (Mittiga *et al.*, 2006). It was reported that p-Cu₂O can be prepared by various fabrication processes such as thermal oxidation, electrochemical oxidation, chemical bath deposition and chemical vapor deposition. Low energy conversion efficiency of p-Cu₂O based solar energy conversion devices is due to the prevention of the photo-generated charge carrier separation in the micron-sized Cu₂O grains on the surface enhancing the recombination process. If the grains radius is reduced from micron to nano-size, the opportunities for recombination can be dramatically reduced enhancing the light absorption properties of the films. Therefore, the preparation of nano-crystalline Cu₂O thin films is a key factor to improve the performance of solar application devices without destroying the crystalline properties of the Cu₂O films. Hence, the present work is aim to fabricate CuO free nano-crystalline p-Cu₂O by thermal oxidation of copper sheets under maintaining slow heating rate for the first time. Structural and photoelectrochemical properties are also aimed to study.

Methodology

The outer layers of commercially available (99.99% purity) copper sheets 2cm×4cm were removed by sand papers and polished with Brasso Metal Polisher until obtaining a mirror like surface. Thereafter, polished copper sheets were washed with a surface detergent and distilled water several times. Well cleaned copper sheets were inserted into a Quartz Tube in a Cabolite-301 Tube Furnace opening both ends by filling normal air during the oxidation process. Initially a heating rate 10 °C/min was provided inside the furnace with copper sheets starting from the room temperature. After reaching 300 °C, 400 °C, 450 °C and 700 °C the temperature kept constant for 30min and then cooled down to room temperature. Experimentally that it was found that the 10°C/min heating rate was the most suitable to fabricate mechanically stable p-Cu₂O on copper sheets. Samples prepared above 450 °C temperature profiles did not produce mechanically stable Cu₂O films on copper sheets. Furnace temperature below 300 °C was not sufficient to oxidize copper sheets to form quality Cu₂O surfaces. Fig.2 shows the appearance of the Cu₂O films

prepared. Four different surface colors exhibited at each temperature profile expecting four different surface morphologies.

Result and Discussion

Fig.01 shows the diffuse reflectance spectra for the samples prepared from 300°C, 400°C, 450°C and 700°C temperature profiles. For the samples prepared from 300°C, 400°C and 450°C temperature profiles show absorption edges 630nm, 620 nm and 600nm, to the band gaps 1.98eV, 2.0eV and 2.1 eV due to band to band transitions of Cu₂O. Band gap 1.4eV for an absorption edge ≈850nm can be observed for CuO crystals prepared from 700°C temperature profile. It should be mentioned that the absorption edges for Cu₂O corresponding to the 300°C, 400 °C and 450°C temperature profiles cannot be observed clearly for the samples prepared at 700°C temperature profile as shown. So that, it can be concluded the most light is absorbed by CuO regions than the Cu₂O regions for the samples prepared from 700°C temperature profile.

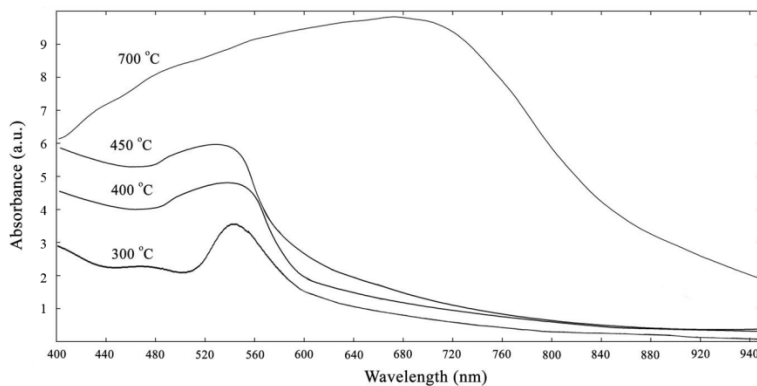


Figure01- Diffuse reflectance spectra of the p-Cu₂O thin films fabricated from 300°C, 400°C, 450°C temperature profiles and p-CuO fabricated from 700°C temperature profile

Table 01- Crystallite sizes estimated from XRD and AFM images prepared from 300°C, 400°C, 450°C and 700°C temperature profiles

	XRD (nm)	AFM (nm)
300 °C	312.2	308.9
400 °C	486.1	488.3
450 °C	393.4	395.1
700 °C	320.7	322.3

Table 01 shows the crystallite sizes estimated from XRD and AFM images obtained from samples prepared from 300°C, 400°C, 450°C and 700°C temperature profiles. It shows that the crystallite sizes obtained from both XRD and AFM are in good agreement of nano meter range.

According to figure 02 that the flat band potential for three samples are almost same ($\approx +.53$ vs Ag/AgCl). Here it is assumed that the flat band potentials are nearly equal to the valance band (VB) position of the samples prepared from each temperature profile. The H⁺/H₂ (-0.61V vs Ag/AgCl at pH=7) and O₂/H₂O (+.62V vs Ag/AgCl at pH=7) were obtained from the literature (Nian *et. Al.*, 2008). It should be mentioned that the conduction band (CB) position of the samples prepared from 300°C, 400°C and 450°C profiles is more negative than the H⁺/H₂ redox level showing a favorable CB band position to reduce water. Highest H₂ evolution rate was observed for the Cu₂O thin films prepared from 450°C temperature profiles in the presence of 1M Na₂SO₄ at -0.4V vs Ag/AgCl biased potential may be due to the more negative CB position as shown in Figure 02. Highest photocurrent ($\approx 10 \text{ mAcm}^{-2}$) was observed for sample prepared from 450°C temperature profile under above experimental conditions is a remarkable finding.

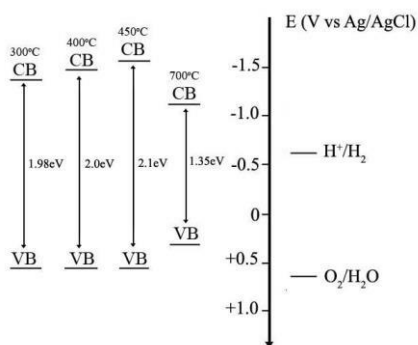


Figure 02- estimated band positions of nano-surfaces, H⁺/H₂ and O₂/H₂O redox levels prepared from 300°C, 400°C, 450°C and 700°C temperature profiles

Conclusions

p-Cu₂O films prepared from 300°C, 400°C and 450°C temperature profiles with 10°C/min slow heating rate produced single phase Cu₂O nano-crystals and the films fabricated from 700°C temperature profile coexist Cu₂O and CuO two phases. A blue shift of the band gap of Cu₂O was observed for the Cu₂O fabricated from the 450°C temperature profile with compared to the Cu₂O films fabricated from 300°C and 400°C temperature profiles may due to the quantum confinement effect of the crystal sizes as exhibited from AFM micrographs. The highest H₂ evolution ($\approx 6.2 \text{ Moles l}^{-1} \text{ min}^{-1}$) and photo-current enhancement ($\approx 10 \text{ mAcm}^{-2}$) from p-Cu₂O nano-surfaces fabricated from 450°C temperature profile was observed with compared to the recent studies presented by Gratzel and co-workers (Paracchino *et al.*, 2011) and the similar systems reported in the literature.

References

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